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## Trench gate field-stop IGBT, M series 650 V, 4 A low loss

Datasheet - production data

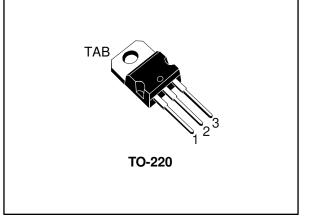
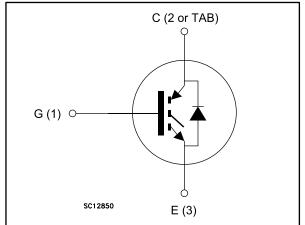


Figure 1: Internal schematic diagram



### **Features**

- 6 µs of short-circuit withstand time
- V<sub>CE(sat)</sub> = 1.6 V (typ.) @ I<sub>C</sub> = 4 A
- Tight parameter distribution
- Safer paralleling
- Low thermal resistance
- Soft and very fast recovery antiparallel diode

### **Applications**

- Motor control
- UPS
- PFC

### Description

This device is an IGBT developed using an advanced proprietary trench gate field-stop structure. The device is part of the M series IGBTs, which represent an optimal balance between inverter system performance and efficiency where low-loss and short-circuit functionality are essential. Furthermore, the positive  $V_{CE(sat)}$  temperature coefficient and tight parameter distribution result in safer paralleling operation.

Table 1: Device summary	Table	1: Dev	vice sumr	narv
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Order code	Marking	Package	Packing
STGP4M65DF2	G4M65DF2	TO-220	Tube

DocID028671 Rev 3

This is information on a product in full production.

### Contents

### Contents

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## 1 Electrical ratings

 Table 2: Absolute maximum ratings

Symbol	Parameter	Value	Unit
VCES	Collector-emitter voltage (V <sub>GE</sub> = 0 V)	650	V
1-	Continuous collector current at T <sub>C</sub> = 25 °C	8	А
lc	Continuous collector current at Tc = 100 °C	4	А
ICP <sup>(1)</sup>	Pulsed collector current	16	А
$V_{GE}$	Gate-emitter voltage	±20	V
1_	Continuous forward current at $T_C = 25 \text{ °C}$	8	А
IF	Continuous forward current at $T_c = 100 \ ^\circ C$	4	А
I <sub>FP</sub> <sup>(1)</sup>	Pulsed forward current	16	А
Ртот	Total dissipation at $T_C = 25 \text{ °C}$	68	W
Tstg	Storage temperature range	- 55 to 150	°C
TJ	Operating junction temperature range	- 55 to 175	°C

#### Notes:

 $^{(1)}\mbox{Pulse}$  width limited by maximum junction temperature.

#### Table 3: Thermal data

Symbol	Parameter	Value	Unit
RthJC	Thermal resistance junction-case IGBT	2.2	°C/W
RthJC	Thermal resistance junction-case diode	5	°C/W
RthJA	Thermal resistance junction-ambient	62.5	°C/W



# 2 Electrical characteristics

 $T_C = 25$  °C unless otherwise specified

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
$V_{(BR)CES}$	Collector-emitter breakdown voltage	$V_{GE}=0~V,~I_C=250~\mu A$	650			V
		$V_{GE} = 15 V$ , $I_C = 4 A$		1.6	2.1	
V <sub>CE(sat)</sub>	Collector-emitter saturation voltage	$\label{eq:VGE} \begin{array}{l} V_{GE} = 15 \ V, \ I_C = 4 \ A, \\ T_J = 125 \ ^\circ C \end{array}$		1.9		v
	volage	$V_{GE} = 15 \text{ V}, I_C = 4 \text{ A},$ $T_J = 175 ^{\circ}\text{C}$		2.1		
		IF = 4 A		1.9		
VF	Forward on-voltage	I <sub>F</sub> = 4 A, T <sub>J</sub> = 125 °C		1.7		V
		I⊧ = 4 A, TJ = 175 °C		1.6		
$V_{GE(th)}$	Gate threshold voltage	$V_{CE} = V_{GE}, I_C = 250 \ \mu A$	5	6	7	V
I <sub>CES</sub>	Collector cut-off current	$V_{GE} = 0 V, V_{CE} = 650 V$			25	μA
IGES	Gate-emitter leakage current	$V_{CE}=0~V,~V_{GE}=\pm~20~V$			±250	μA

#### Table 4: Static characteristics

#### Table 5: Dynamic characteristics

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
Cies	Input capacitance		-	369	-	
Coes	Output capacitance	V <sub>CE</sub> = 25 V, f = 1 MHz,	I	24.8	-	рF
Cres	Reverse transfer capacitance	V <sub>GE</sub> = 0 V	-	8	-	μ.
Qg	Total gate charge	Vcc = 520 V, Ic = 4 A,	-	15.2	-	
Q <sub>ge</sub>	Gate-emitter charge	V <sub>GE</sub> = 15 V (see <i>Figure 30: " Gate charge</i>	-	3	-	nC
Q <sub>gc</sub>	Gate-collector charge	test circuit")	-	7	-	



#### Electrical characteristics

	Table 6: IGBT switching characteristics (inductive load)						
Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit	
td(on)	Turn-on delay time			12	-	ns	
tr	Current rise time			6.9	-	ns	
(di/dt) <sub>on</sub>	Turn-on current slope	$V_{CE} = 400 V, I_{C} = 4 A,$		480	-	A/µs	
td(off)	Turn-off-delay time	$V_{GE} = 15 \text{ V}, \text{ R}_{G} = 47 \Omega$		86	-	ns	
t <sub>f</sub>	Current fall time	(see Figure 29: " Test circuit for inductive load		120	-	ns	
Eon <sup>(1)</sup>	Turn-on switching energy	switching")		0.040	-	mJ	
Eoff <sup>(2)</sup>	Turn-off switching energy			0.136	-	mJ	
Ets	Total switching energy			0.176	-	mJ	
td(on)	Turn-on delay time			11.6	-	ns	
tr	Current rise time			8	-	ns	
(di/dt) <sub>on</sub>	Turn-on current slope	$V_{CE} = 400 V, I_{C} = 4 A,$		410	-	A/µs	
td(off)	Turn-off-delay time	V <sub>GE</sub> = 15 V, R <sub>G</sub> = 47 Ω, T <sub>i</sub> = 175 °C		85	-	ns	
tr	Current fall time	(see Figure 29: " Test circuit		211	-	ns	
Eon <sup>(1)</sup>	Turn-on switching energy	for inductive load switching")		0.067	-	mJ	
Eoff <sup>(2)</sup>	Turn-off switching energy			0.210	-	mJ	
Ets	Total switching energy			0.277	-	mJ	
+	Short-circuit withstand time	$\label{eq:VCC} \begin{array}{l} V_{CC} \leq 400 \ V, \ V_{GE} = 15 \ V, \\ T_{Jstart} = 150 \ ^{\circ}C \end{array}$	6		-	μs	
t <sub>sc</sub>	Short-circuit withstand lime	$\label{eq:VCC} \begin{array}{l} V_{CC} \leq 400 \ V, \ V_{GE} = 13 \ V, \\ T_{Jstart} = 150 \ ^{\circ}C \end{array}$	10		-	μs	

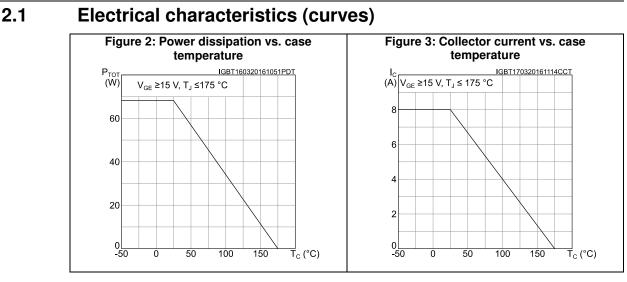
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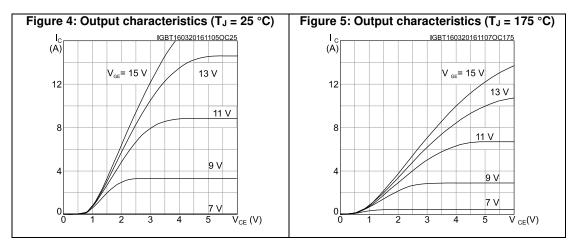
<sup>(1)</sup>Including the reverse recovery of the diode. <sup>(2)</sup>Including the tail of the collector current.

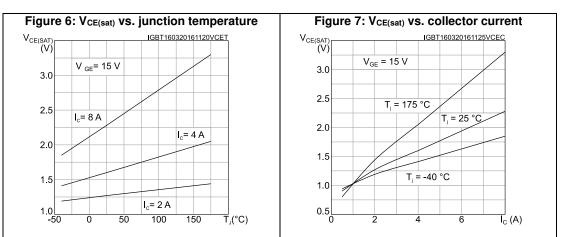
Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
trr	Reverse recovery time		-	133	-	ns
Q <sub>rr</sub>	Reverse recovery charge	I <sub>F</sub> = 4 A, V <sub>B</sub> = 400 V,	-	140	-	nC
Irrm	Reverse recovery current	V <sub>GE</sub> = 15 V, di/dt = 800 A/µs	-	5	-	А
dlrr/dt	Peak rate of fall of reverse recovery current during tb	(see Figure 29: " Test circuit for inductive load switching")	-	520	-	A∕µs
Err	Reverse recovery energy		-	15	-	μJ
t <sub>rr</sub>	Reverse recovery time		-	236	-	ns
Qrr	Reverse recovery charge	$I_F = 4 A, V_R = 400 V,$	-	370	-	nC
Irrm	Reverse recovery current	V <sub>GE</sub> = 15 V, T <sub>J</sub> = 175 °C, di/dt = 800 A/μs	-	6.6	-	А
dlrr/dt	Peak rate of fall of reverse recovery current during tb	(see Figure 29: " Test circuit for inductive load switching")	-	378	-	A∕µs
Err	Reverse recovery energy		-	32	-	μJ

Table 7: Diode switching	characteristics	(inductive load)



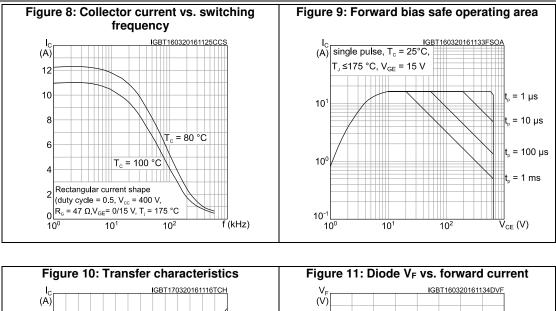


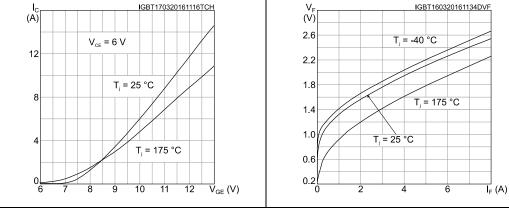


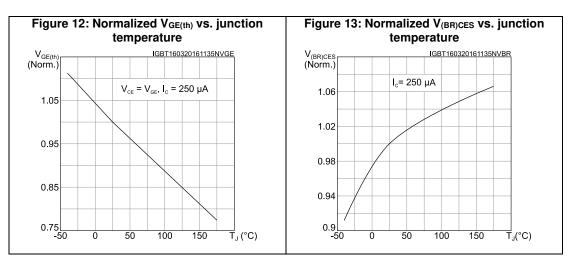




#### **Electrical characteristics**



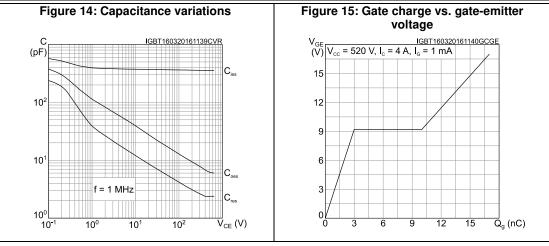


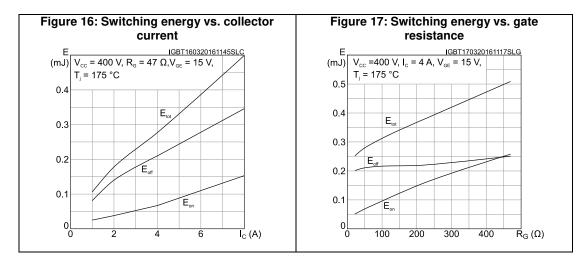


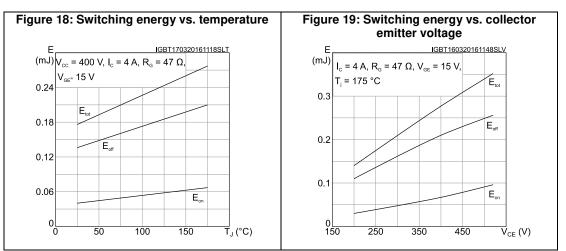


#### **Electrical characteristics**

#### STGP4M65DF2



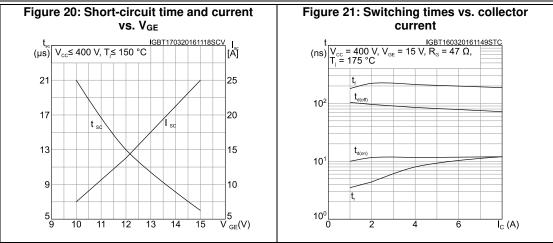


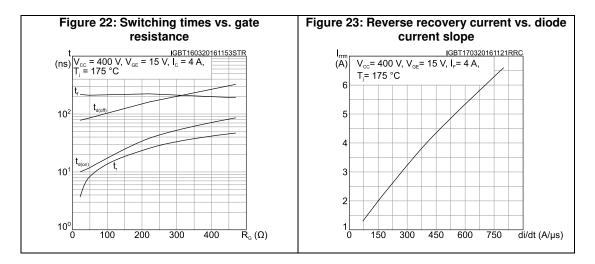


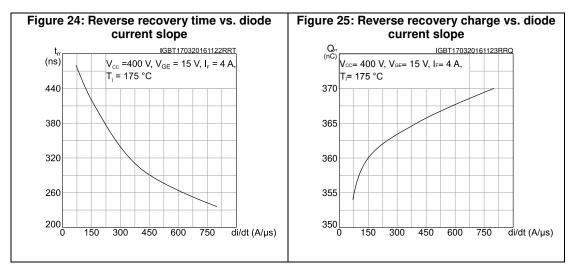


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#### **Electrical characteristics**

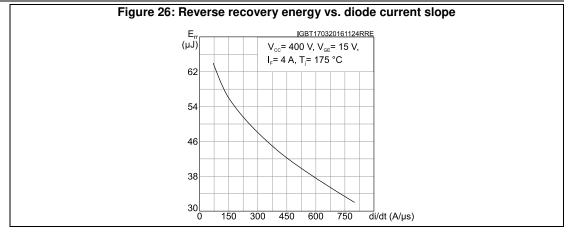


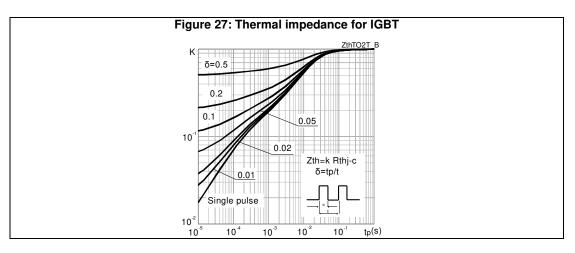


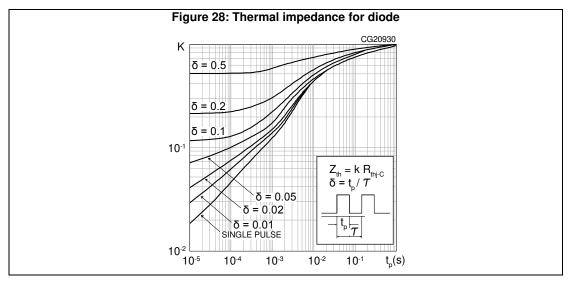


#### **Electrical characteristics**

#### STGP4M65DF2

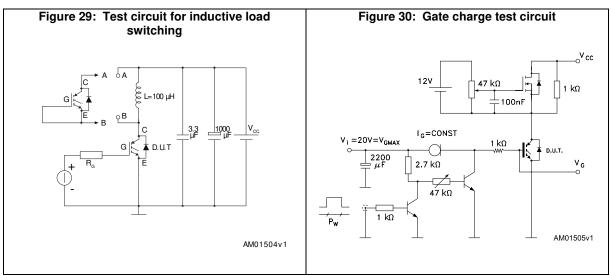


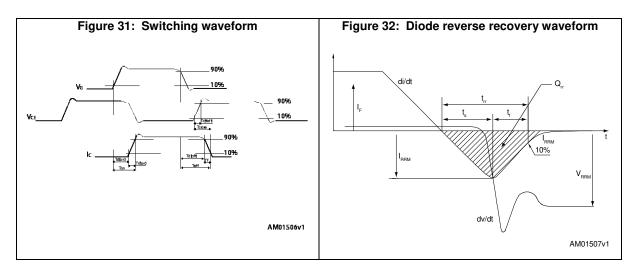






### 3 Test circuits







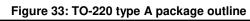
### 4 Package information

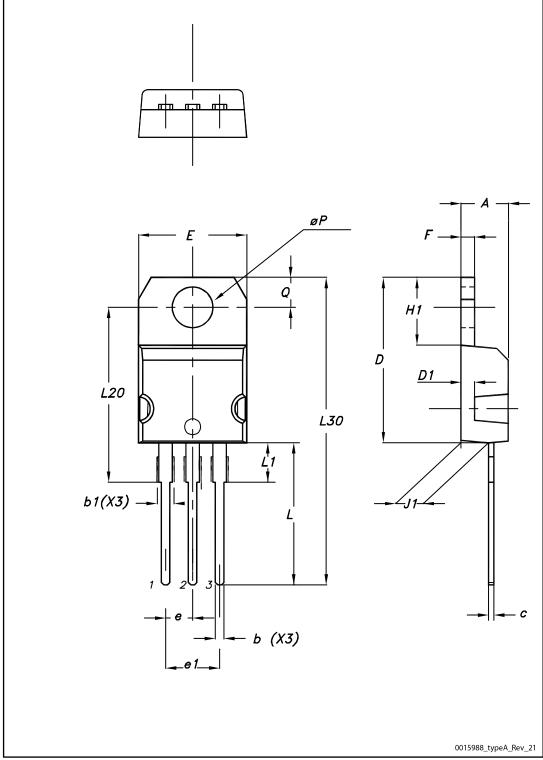
In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK<sup>®</sup> packages, depending on their level of environmental compliance. ECOPACK<sup>®</sup> specifications, grade definitions and product status are available at: *www.st.com*. ECOPACK<sup>®</sup> is an ST trademark.



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### 4.1 TO-220 type A package information





#### Package information

#### STGP4M65DF2

normation					
[	Table 8: TO-220 ty	pe A mechanical data			
Dim.		mm			
Dim.	Min.	Тур.	Max.		
А	4.40		4.60		
b	0.61		0.88		
b1	1.14		1.55		
С	0.48		0.70		
D	15.25		15.75		
D1		1.27			
E	10.00		10.40		
е	2.40		2.70		
e1	4.95		5.15		
F	1.23		1.32		
H1	6.20		6.60		
J1	2.40		2.72		
L	13.00		14.00		
L1	3.50		3.93		
L20		16.40			
L30		28.90			
øP	3.75		3.85		
Q	2.65		2.95		



# 5 Revision history

Table 9: Document revision history

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Date	Revision	Changes
25-Nov-2015	1	First release.
30-Mar-2016	2 Modified: features in cover page Datasheet promoted from preliminary data to production data Modified: Table 2: "Absolute maximum ratings", Table 4: "Static characteristics", Table 5: "Dynamic characteristics", Table 6: "IGBT switching characteristics (inductive load)" and Table 7: "Diode switch characteristics (inductive load)" Added: Section 2.1: "Electrical characteristics (curves)" Minor text changes	
21-Nov-2016	3	Updated <i>Table 2:</i> "Absolute maximum ratings" Updated <i>Table 6:</i> "IGBT switching characteristics (inductive load)" Updated <i>Figure 25:</i> "Reverse recovery charge vs. diode current slope" Minor text changes



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